

MOSFET - N-Channel POWERTRENCH®

75 V, 100 A, 3.7 m Ω

FDMS037N08B

Description

This N-Channel MOSFET is produced using **onsemi**'s advanced POWERTRENCH process that has been tailored to minimize the on-state resistance and while maintaining superior switching performance.

Features

- $R_{DS(on)} = 3.01 \text{ m}\Omega \text{ (Typ.)} @ V_{GS} = 10 \text{ V}, I_D = 50 \text{ A}$
- Low FOM R_{DS(on)}*Q_G
- Low Reverse Recovery Charge, $Q_{rr} = 80 \text{ nC}$
- Soft Reverse Recovery Body Diode
- Enables Highly Efficiency in Synchronous Rectification
- Fast Switching Speed
- 100% UIL Tested
- These Device is Pb-Free and RoHS Compliant

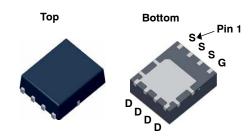
Applications

- Synchronous Rectification for ATX / Server / Telecom PSU
- Battery Protection circuit
- DC Motor Drives and Uninterruptible Power Supplies

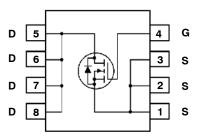
MOSFET MAXIMUM RATINGS ($T_A = 25^{\circ}C$ unless otherwise noted.)

| Symbol | Parameter | Value | Unit |
|-----------------------------------|---|--------------------|------|
| V_{DSS} | Drain to Source Voltage | 75 | V |
| V _{GSS} | Gate to Source Voltage | ±20 | V |
| Ι _D | Drain Current - Continuous (T _C = 25°C) - Continuous (T _C = 25°C, Silicon Limited) - Continuous (T _A = 25°C) (Note 1a) | 100 128 19.9 | A |
| I _{DM} | Drain Current - Pulsed (Note 2) | 400 | Α |
| E _{AS} | Single Pulse Avalanche Energy (Note 3) | 180.6 | mJ |
| P _D | Power Dissipation (T _C = 25°C) | 104.2 | W |
| | Power Dissipation (T _A = 25°C) (Note 1a) | 0.83 | |
| T _J , T _{stg} | Operating and Storage Junction Temperature Range | -55 to +150 | °C |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



PQFN8 5X6, 1.27P (Power 56) CASE 483AE



MARKING DIAGRAM

&Z&3&K FDMS 0 037N08B

&Z = Assembly Plant Code&3 = Numeric Date Code&K = 2-Digit Lot Code

FDMS037N08B = Specific Device Code

ORDERING INFORMATION

| Device | Package | Shipping [†] |
|-------------|---------------------|-----------------------|
| FDMS037N08B | PQFN-8 (Pb-Free) | 3000 / Tape & Reel |

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, <u>BRD8011/D</u>.

THERMAL CHARACTERISTICS

| Symbol | Parameter | Value | Unit | |
|-----------------|--|-------|--------|--|
| $R_{	heta JC}$ | Thermal Resistance, Junction to Case, Max | 1.2 | °C AA/ | |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient, Max (Note 1a) | 50 | °C/W | |

ELECTRICAL CHARACTERISTICS (T_{.1} = 25°C unless otherwise noted)

| Symbol | Parameter | Test Conditions | Min | Тур | Max | Unit |
|--|--|--|-----|------|------|-------|
| Off Charac | cteristics | | | | | |
| BV_DSS | Drain to Source Breakdown Voltage | $I_D = 250 \mu A, V_{GS} = 0 V$ | 75 | - | - | V |
| $\frac{\Delta BV_{DSS}}{\Delta T_{J}}$ | Breakdown Voltage Temperature Coefficient | I_D = 250 μ A, Referenced to 25°C | - | 39 | _ | mV/°C |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} = 60 V, V _{GS} = 0 V | - | - | 1 | μΑ |
| I _{GSS} | Gate to Body Leakage Current | V _{GS} = ±20 V, V _{DS} = 0 V | _ | - | ±100 | nA |
| On Charac | cteristics | | | | | |
| V _{GS(th)} | Gate Threshold Voltage | $V_{GS} = V_{DS}, I_D = 250 \mu A$ | 2.5 | - | 4.5 | V |
| R _{DS(on)} | Static Drain-Source On-Resistance | V _{GS} = 10 V, I _D = 50 A | - | 3.01 | 3.7 | mΩ |
| 9 _{FS} | Forward Transconductance | $V_{DS} = 10 \text{ V}, I_D = 50 \text{ A}$ | - | 108 | - | S |
| Dynamic 0 | Characteristics | | | | | |
| C _{iss} | Input Capacitance | $V_{DS} = 37.5 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$ | - | 4550 | 5915 | pF |
| C _{oss} | Output Capacitance | | - | 1060 | 1380 | pF |
| C _{rss} | Reverse Transfer Capacitance | | - | 30.2 | 45 | pF |
| C _{oss} (er) | Energy Releted Output Capacitance | V _{DS} = 37.5 V, V _{GS} = 0 V | - | 1702 | - | pF |
| Q _{g(tot)} | Total Gate Charge at 10 V | V _{DS} = 37.5 V, I _D = 50 A V _{GS} = 0 V, to 10 V (Note 4) | - | 76.8 | 100 | nC |
| Q_{gs} | Gate to Source Gate Charge | | - | 27.5 | - | nC |
| Q_{gd} | Gate to Drain "Miller" Charge | 7 | - | 17.4 | - | nC |
| V _{plateau} | Gate to Drain Plateau Voltage | 7 | - | 5.1 | - | V |
| Q _{sync} | Total Gate Charge Sync | V _{DS} = 0 V, I _D = 50 A | - | 66.3 | - | nC |
| Q _{oss} | Output Charge | V _{DS} = 37.5 V, V _{GS} = 0 V | - | 74.6 | - | nC |
| ESR | Equivalent Series Resistance | f = 1 MHz | - | 1.28 | _ | Ω |
| Switching | Characteristics | | | | | |
| t _{d(on)} | Turn-On Delay Time | $V_{DD} = 37.5 \text{ V}, I_D = 50 \text{ A},$ | - | 34.9 | 80 | ns |
| t _r | Turn-On Rise Time | $V_{GS} = 10 \text{ V}, R_G = 4.7 \Omega \text{ (Note 4)}$ | - | 20.1 | 50 | ns |
| t _{d(off)} | Turn-Off Delay Time | | - | 55.3 | 120 | ns |
| t _f | Turn-Off Fall Time | | - | 19.4 | 49 | ns |
| Drain-Sοι | urce Diode Characteristics and Maximum | Ratings | | | | |
| I _S | Maximum Continuous Drain to Source Diode Forward Current | | - | - | 100 | Α |
| I _{SM} | Maximum Pulsed Drain to Source Diode Forward Current | | - | - | 400 | Α |
| V_{SD} | Drain to Source Diode Forward Voltage | V _{GS} = 0 V, I _{SD} = 50 A | - | - | 1.3 | V |
| t _{rr} | Reverse Recovery Time | V _{GS} = 0 V, I _{SD} = 50 A | - | 66.8 | - | ns |
| Q _{rr} | Reverse Recovery Charge | dl _F /dt = 100 A/μs | _ | 84 | _ | nC |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

NOTES:

1. $R_{\theta JA}$ is determined with the device mounted on a 1 in² oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a).50 °C/W when mounted on a 1 in 2 pad of 2 oz copper.



b).125 °C/W when mounted on a minimum pad of 2 oz copper.

- $\begin{array}{ll} 2. & \text{Repetitive rating: pulse-width limited by maximum junction temperature.} \\ 3. & L=0.3 \text{ mH, I}_{AS}=34.7 \text{ A, starting T}_{J}=25^{\circ}\text{C.} \\ 4. & \text{Essentially independent of operating temperature typical characteristics.} \\ \end{array}$

TYPICAL CHARACTERISTICS

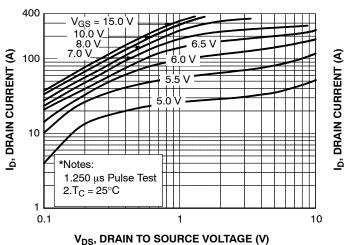


Figure 1. On–Region Characteristics

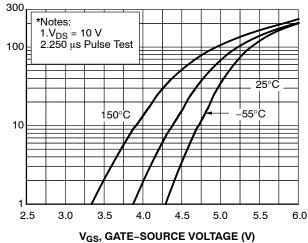


Figure 2. Transfer Characteristics

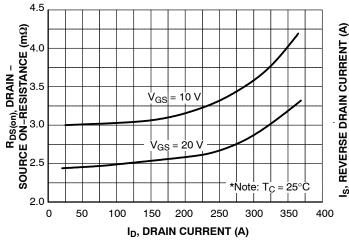


Figure 3. On-Resistance Variation vs Drain Current and Gate Voltage

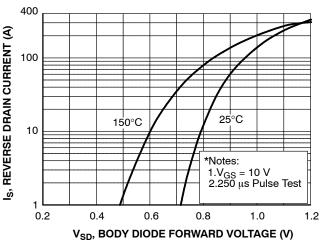


Figure 4. Body Diode Forward Voltage Variation vs Source Current and Temperature

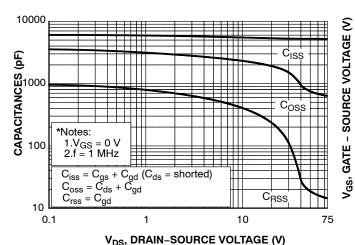


Figure 5. Capacitance Characteristics

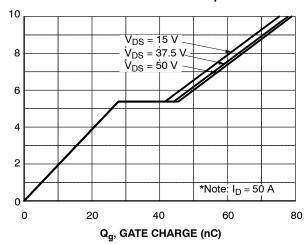


Figure 6. Gate Charge Characteristics

TYPICAL CHARACTERISTICS (CONTINUED)

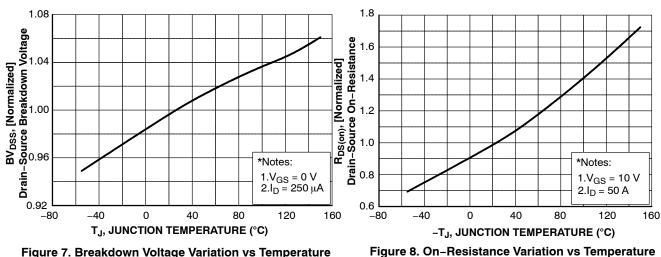
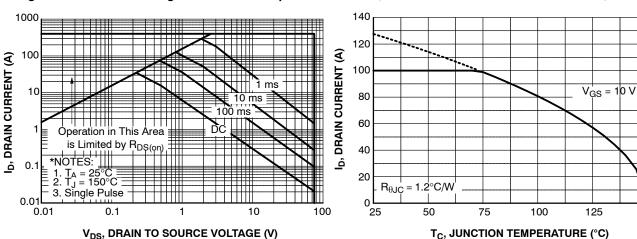


Figure 7. Breakdown Voltage Variation vs Temperature



V_{DS}, DRAIN TO SOURCE VOLTAGE (V) Figure 9. Maximum Safe Operating Area

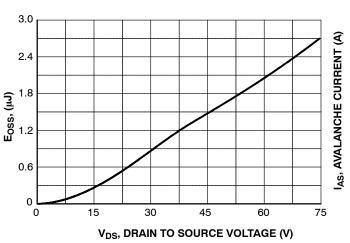


Figure 11. Eoss vs. Drain to Source Voltage

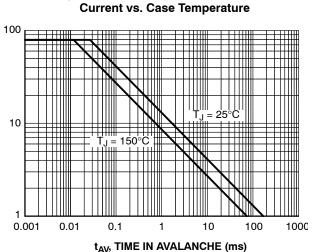


Figure 10. Maximum Continuous Drain

150

Figure 12. Unclamped Inductive **Switching Capability**

TYPICAL CHARACTERISTICS (CONTINUED)

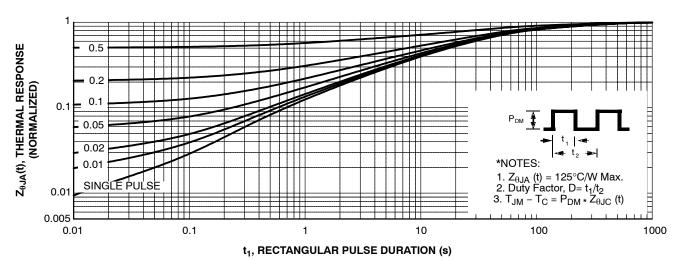


Figure 13. Transient Thermal Response Curve

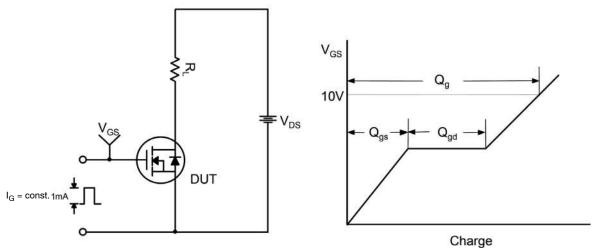


Figure 14. Gate Charge Test Circuit & Waveform

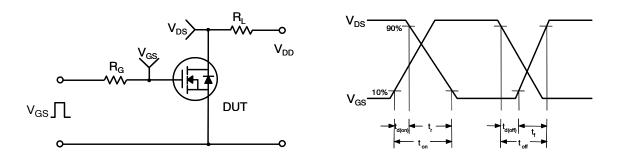


Figure 15. Resistive Switching Test Circuit & Waveforms

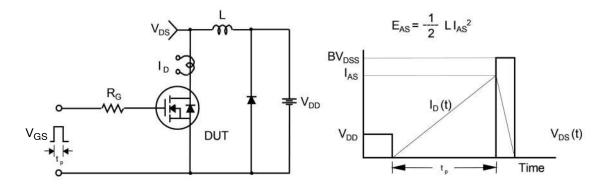
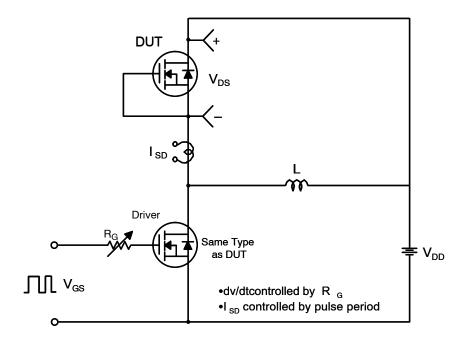


Figure 16. Unclamped Inductive Switching Test Circuit & Waveforms



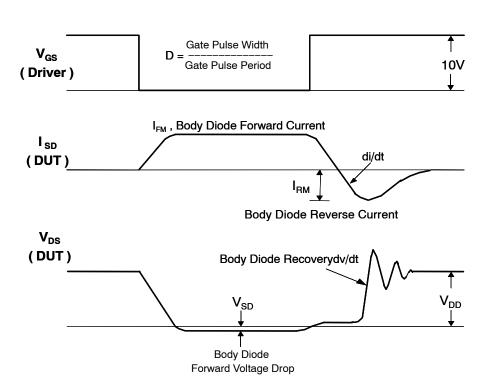


Figure 17. Peak Diode Recovery dv/dt Test Circuit & Waveforms

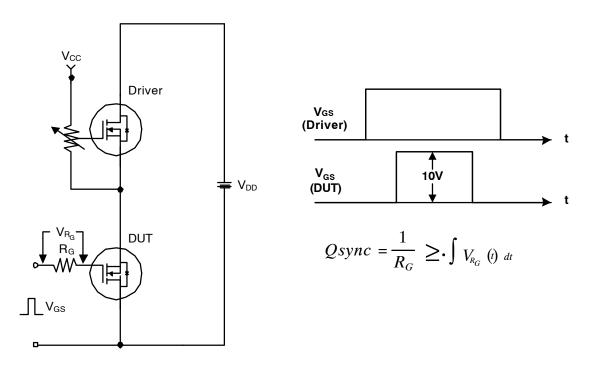


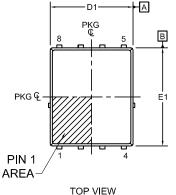
Figure 18. Total Gate Charge Qsync. Test Circuit & Waveforms

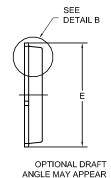
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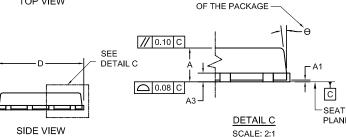


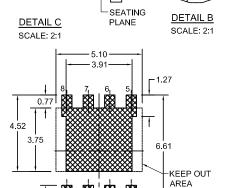


ON FOUR SIDES

NOTES:

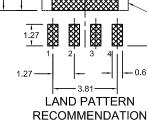
- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. COPLANARITY APPLIES TO THE EXPOSED PADS AS WELL AS THE TERMINALS.
- 4. DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.
- 5. SEATING PLANE IS DEFINED BY THE TERMINALS. "A1" IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.
- 6. IT IS RECOMMENDED TO HAVE NO TRACES OR VIAS WITHIN THE KEEP OUT AREA.





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*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

| DIM | MILLIMETERS | | | |
|-------|-------------|----------|------|--|
| Diivi | MIN. | NOM. | MAX. | |
| Α | 0.90 | 1.00 | 1.10 | |
| A1 | 0.00 | - | 0.05 | |
| b | 0.21 | 0.31 | 0.41 | |
| b1 | 0.31 | 0.41 | 0.51 | |
| А3 | 0.15 | 0.25 | 0.35 | |
| D | 4.90 | 5.00 | 5.20 | |
| D1 | 4.80 | 4.90 | 5.00 | |
| D2 | 3.61 | 3.82 | 3.96 | |
| E | 5.90 | 6.15 | 6.25 | |
| E1 | 5.70 | 5.80 | 5.90 | |
| E2 | 3.38 | 3.48 | 3.78 | |
| E3 | (| 0.30 REF | | |
| E4 | 0.52 REF | | | |
| е | 1.27 BSC | | | |
| e/2 | 0.635 BSC | | | |
| e1 | 3.81 BSC | | | |
| e2 | 0.50 REF | | | |
| L | 0.51 | 0.66 | 0.76 | |
| L2 | 0.05 | 0.18 | 0.30 | |
| L4 | 0.34 | 0.44 | 0,54 | |
| z | 0.34 REF | | | |
| θ | 0° | - | 12° | |

| (z) (4X) — — — — — — — — — — — — — — — — — — — | |
|--|--|
| (E3) (E3) (2X) b (8X) D2 | |
| BOTTOM VIEW | |

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|------------------|--|--|-------------|
| DESCRIPTION: | PQFN8 5X6, 1.27P | | PAGE 1 OF 1 |

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